Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	Applicant(s)/Patent under Reexamination	
10/532,471	MITANI, YOHSUKE	MITANI, YOHSUKE	
Examiner	Art Unit		

3661

Dalena Tran

	SEAR	CHED	
Class	Subclass	Date	Examiner
701	71 -		
180	117		
	203		
	165		
	6.28		
	167		
303	9.63	9-1107	75
	3,122		
	12201		
•	12.04		
	124		
	132		
	133		
	134		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			1	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
EAST	6/27/07	121	
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